

<b>Notice of References Cited</b>	Application/Control No. 10/535,654	Applicant(s)/Patent Under Reexamination FURUHI ET AL.	
	Examiner Chuc D. Tran	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,971,022	07-1976	Lenz, Karl-Ludwig	343/754
*	C	US-4,381,566	04-1983	Kane, Johji	455/193.3
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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